



Join a Local Affiliated Society (LAS)!

MSA currently has 32 independent local affiliated societies (or LAS's) from which to choose!

Through a local society membership, you gain access to extensive educational materials & activities. Local events are a great way to connect with your peers and expand your knowledge of microscopy, while minimizing time and expense.

Having a membership in a local affiliate is also a great way to build a network of local professionals any time of the year. Become a volunteer in your local society and help advance the public's understanding and appreciation of microscopy!

To help these local affiliated societies host successful meetings, MSA offers assistance through several programs including the Tour Speaker and Meeting Funding programs.

Most local affiliates offer you the opportunity to join online. A small additional fee is required, and varies by LAS. Visit the MSA web site for a list of current local affiliates and their home pages.

<http://www.microscopy.org/communities/local.cfm>

Join a Focused Interest Group (FIG)!

The world of microscopy is becoming more and more specialized each day. And your time is more precious than ever before. At the same time, there is an increasing need to connect with peers with a focus in specific areas of microscopy. MSA wants you to have access to all the information that matters to you and your area of expertise.

Perhaps your job focuses on a single area of microscopy. Or perhaps you want to move your career in a different direction and wish to learn something new. MSA strongly encourage every member to join one or more Focused Interest Groups. We like to call them FIGs!

FIGs are only open to current MSA members. For an additional fee of \$10.00, Each FIG provides periodic information on a specific area of interest. And most groups expand on this information through live discussion at the *Microscopy & Microanalysis Annual Meeting* each summer. Approximately nine Focused Interest Groups currently exist and more are constantly in development.

Most MSA members join one or more FIGs online through the normal membership renewal process, but membership is available anytime throughout the year. Visit the MSA web site for a list of current Focused Interest Groups and their primary contacts.

<http://www.microscopy.org/communities/fig.cfm>

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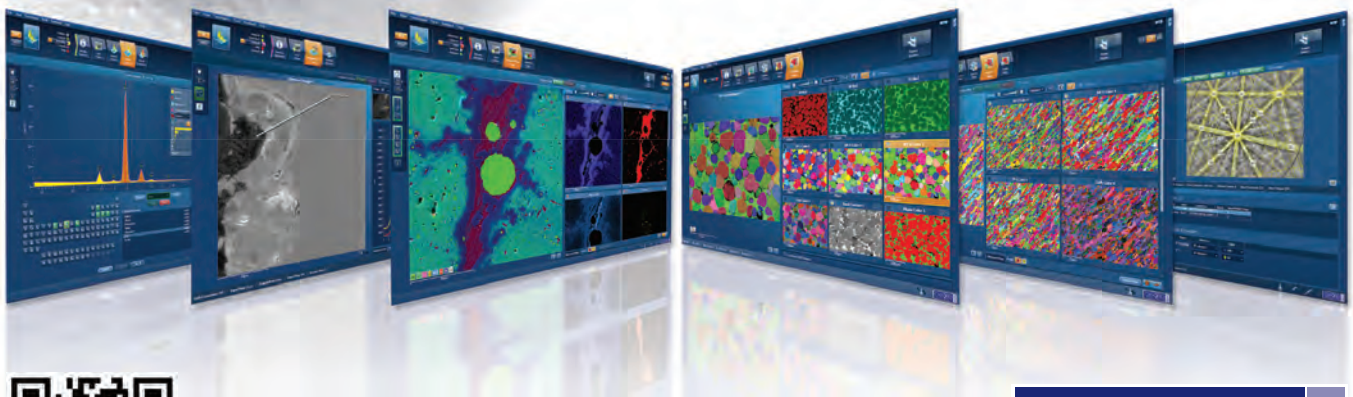
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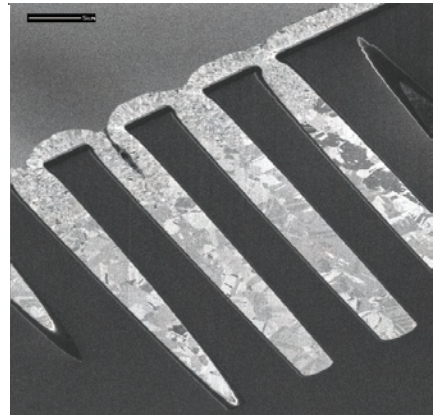
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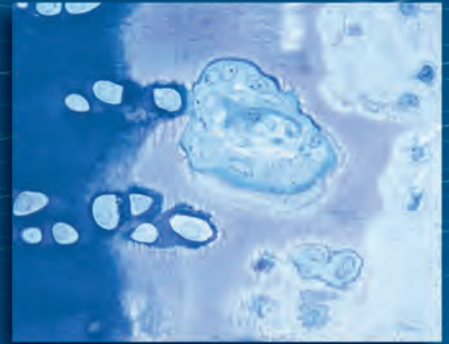
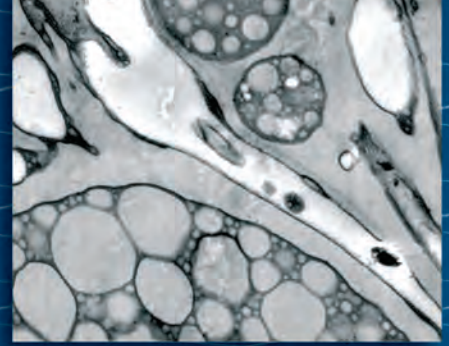
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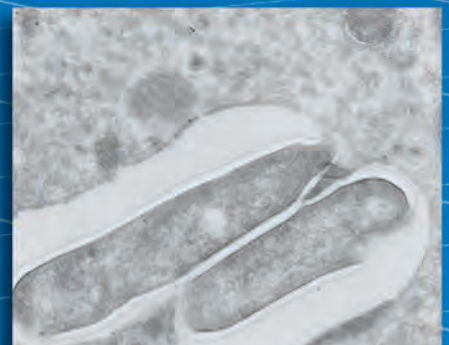
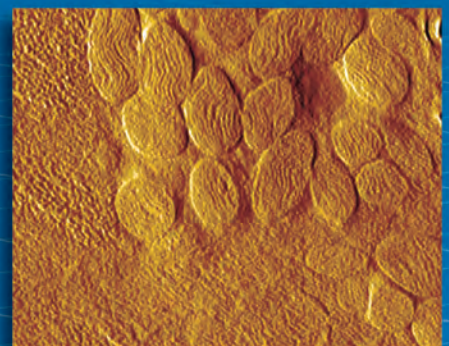
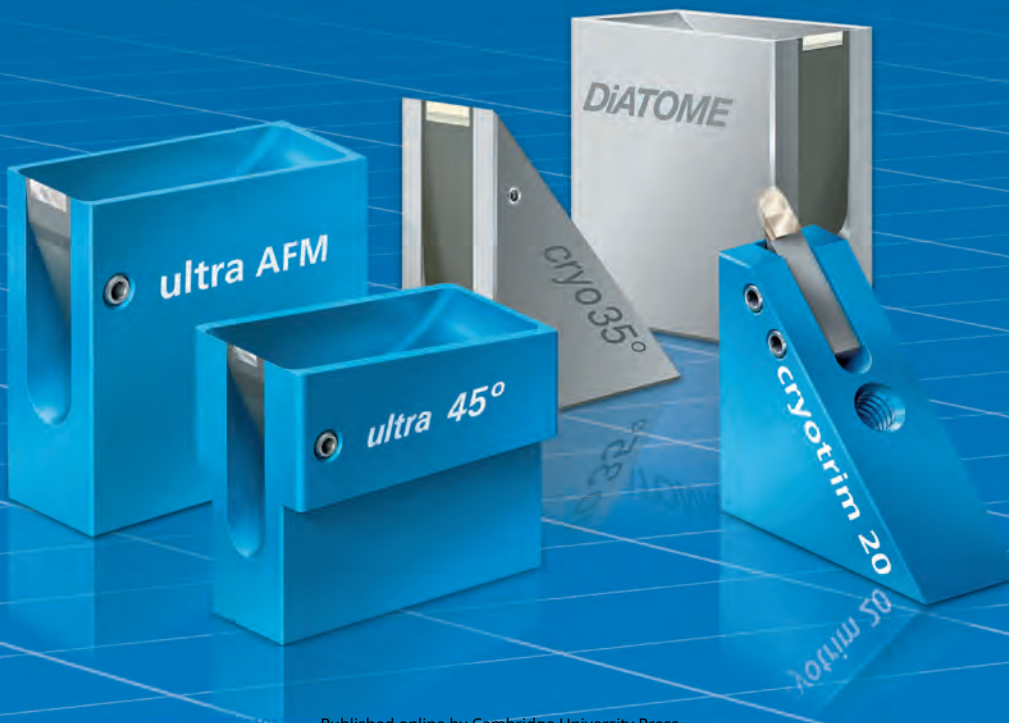
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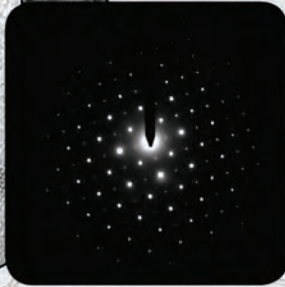
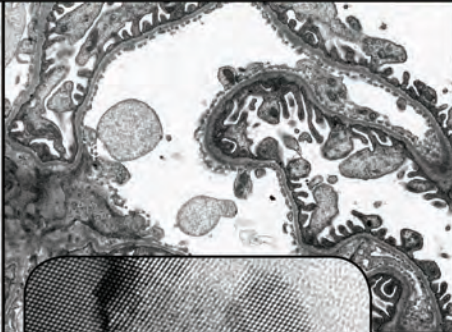
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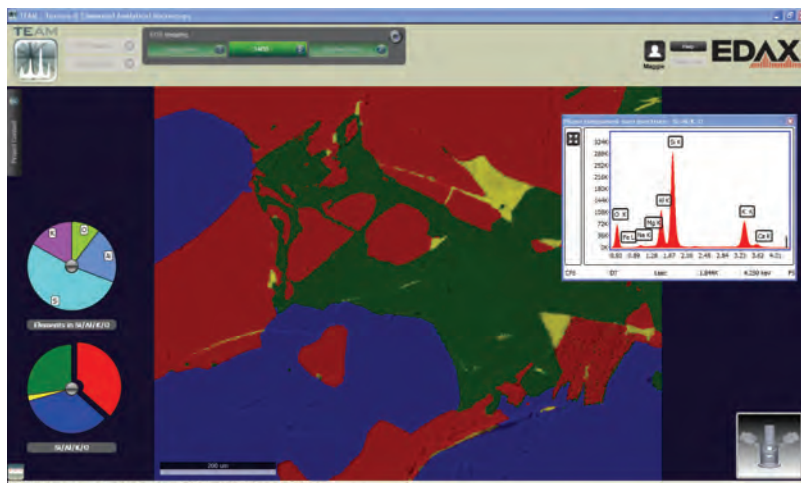
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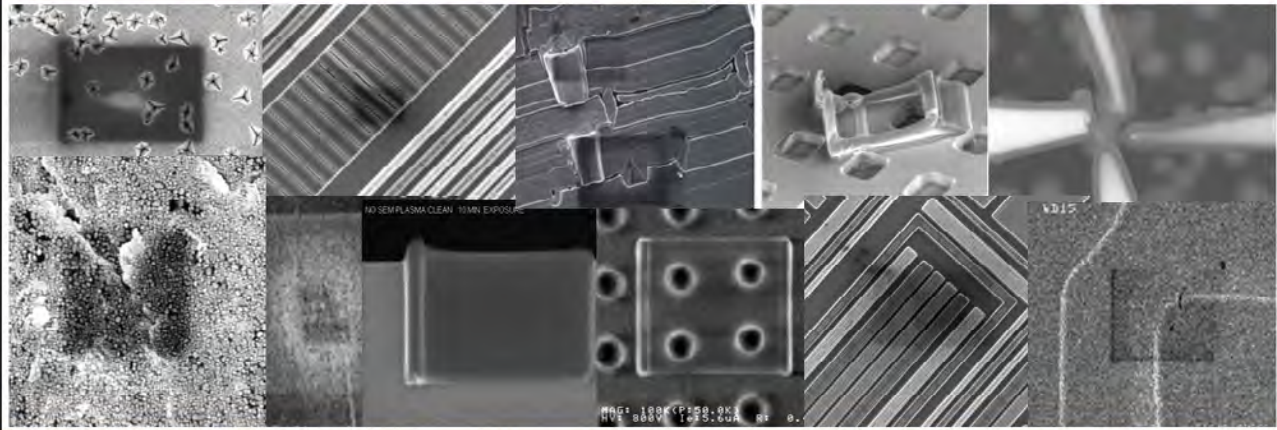


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